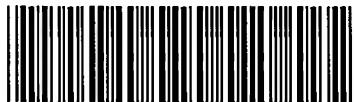


Search Notes**Application/Control No.**

10/645,434

Examiner

Ali Bayat

Applicant(s)/Patent under Reexamination

CHANG ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	232- 233,250- 251,253,2 68	11/21/2006	A.B
375	240.2	11/21/2006	A.B
375	240.03	11/21/2006	A.B
375	240.29	11/21/2006	A.B
358	1.9	11/21/2006	A.B
358	426.14	11/21/2006	A.B

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Wengpeng Chen; EAST (USPGPUB; USPAT; EPO; JPO; DERWENT; IBM-TEB; USOCR; FPRS), see text search history print out.	11/21/2006	A.B
see interference search history print out	11/22/2006	A.B

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
PGPUB	TEXT	11/22/2006	A.B
PGPUB	search	11/22/2006	A.B
Interference search print out		11/22/2006	A.B